SN74LXC8T245-Q1 Automotive 8-bit Dual-Supply Bus Transceiver with Configurable Level Shifting and 3-State Outputs

1 Features

- AEC-Q100 qualified for automotive applications
- Fully configurable dual-rail design allows each port to operate from 1.1 V to 5.5 V
- Robust, glitch-free power supply sequencing
- Up to 420-Mbps support for 3.3 V to 5.0 V
- Schmitt-trigger inputs allow for slow or noisy inputs
- I/Os with integrated dynamic pull-down resistors help reduce external component count
- Control inputs with integrated static pull-down resistors allow for floating control inputs
- High drive strength (up to 32 mA at 5 V)
- Low power consumption:
  - 4-µA maximum (25°C)
  - 12-µA maximum (–40°C to 125°C)
- V_{CC} isolation and V_{CC} disconnect ($I_{off-float}$) feature:
  - If either V_{CC} supply is < 100 mV or disconnected, all I/Os get pulled-down and then become high-impedance
- I_{off} supports partial-power-down mode operation
- Compatible with LVC family level shifters
- Control logic (DIR and $\overline{OE}$) are referenced to V_{CCA}
- Operating temperature from –40°C to +125°C
- Latch-up performance exceeds 100 mA per JESD 78, Class II
- ESD protection exceeds JESD 22
  - 4000-V Human-Body Model
  - 1000-V Charged-Device Model

2 Applications

- Eliminate slow or noisy input signals
- Driving indicator LEDs or buzzers
- Debouncing a mechanical switch
- Infotainment head unit
- ADAS fusion

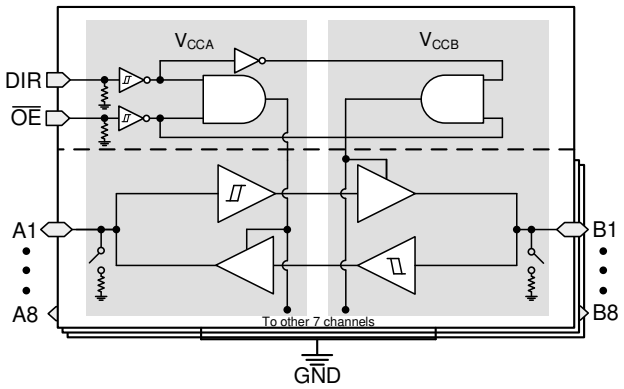
3 Description

The SN74LXC8T245-Q1 is an 8-bit, dual-supply noninverting bidirectional voltage level translation device. Ax pins and control pins (DIR and $\overline{OE}$) are referenced to V_{CCA} logic levels, and Bx pins are referenced to V_{CCB} logic levels. The A port is able to accept I/O voltages ranging from 1.1 V to 5.5 V, while the B port can accept I/O voltages from 1.1 V to 5.5 V. A high on DIR allows data transmission from A to B and a low on DIR allows data transmission from B to A when $\overline{OE}$ is set to low. When $\overline{OE}$ is set to high, both Ax and Bx pins are in the high-impedance state. See *Device Functional Modes* for a summary of the operation of the control logic.

Package Information

PART NUMBER	PACKAGE(1)	BODY SIZE (NOM)
SN74LXC8T245-Q1	PW (TSSOP, 24)	7.80 mm × 6.40 mm
	RHL (VQFN, 24)	5.50 mm × 3.50 mm
	DGS (VSSOP, 24)	6.10 mm × 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Functional Block Diagram

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

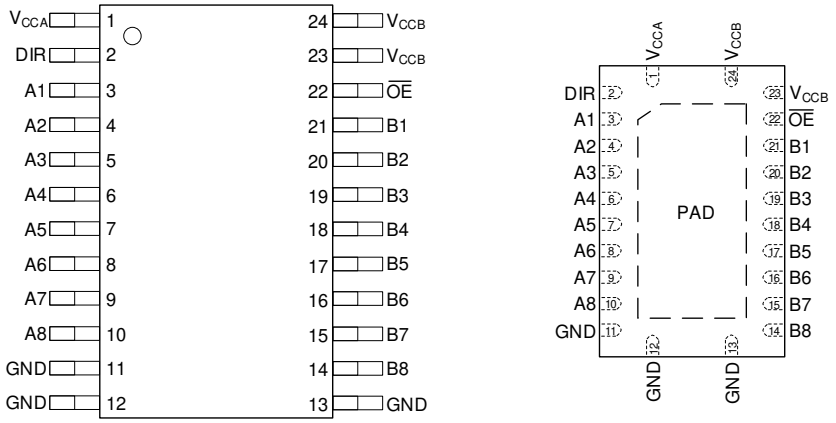
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (November 2020) to Revision B (March 2023)	Page
• Added DGS package information to the data sheet	1

Changes from Revision * (September 2020) to Revision A (November 2020)	Page
• Changed status of data sheet from *Advanced Information* to *Production Data*	1

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5 Pin Configuration and Functions



All packages are on the same relative scale.

Figure 5-1. PW, DGS, and RHL Package, 24-Pin TSSOP, VSSOP, and VQFN (Transparent Top View)

Table 5-1. Pin Functions

PIN		TYPE(1)	DESCRIPTION
NAME	PW, DGS, RHL		
A1	3	I/O	Input or output A1. Referenced to V_{CCA}.
A2	4	I/O	Input or output A2. Referenced to V_{CCA}.
A3	5	I/O	Input or output A3. Referenced to V_{CCA}.
A4	6	I/O	Input or output A4. Referenced to V_{CCA}.
A5	7	I/O	Input or output A5. Referenced to V_{CCA}.
A6	8	I/O	Input or output A6. Referenced to V_{CCA}.
A7	9	I/O	Input or output A7. Referenced to V_{CCA}.
A8	10	I/O	Input or output A8. Referenced to V_{CCA}.
B1	21	I/O	Input or output B1. Referenced to V_{CCB}.
B2	20	I/O	Input or output B2. Referenced to V_{CCB}.
B3	19	I/O	Input or output B3. Referenced to V_{CCB}.
B4	18	I/O	Input or output B4. Referenced to V_{CCB}.
B5	17	I/O	Input or output B5. Referenced to V_{CCB}.
B6	16	I/O	Input or output B6. Referenced to V_{CCB}.
B7	15	I/O	Input or output B7. Referenced to V_{CCB}.
B8	14	I/O	Input or output B8. Referenced to V_{CCB}.
DIR	2	I	Direction-control signal for all ports. Referenced to V_{CCA}.
GND	11	—	Ground.
	12	—	Ground.
	13	—	Ground.
$\overline{OE}$	22	I	Output Enable. Pull to GND to enable all outputs. Pull to V_{CCA} to place all outputs in high-impedance mode. Referenced to V_{CCA}.
V_{CCA}	1	—	A-port supply voltage. 1.1 V ≤ V_{CCA} ≤ 5.5 V.
V_{CCB}	23	—	B-port supply voltage. 1.1 V ≤ V_{CCB} ≤ 5.5 V.
	24	—	B-port supply voltage. 1.1 V ≤ V_{CCB} ≤ 5.5 V.
PAD	—	—	Thermal pad. May be grounded (recommended) or left floating.

(1) I = input, O = output

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V_{CCA}	Supply voltage A		–0.5	6.5	V
V_{CCB}	Supply voltage B		–0.5	6.5	V
V_I	Input Voltage(2)	I/O Ports (A Port)	–0.5	6.5	V
		I/O Ports (B Port)	–0.5	6.5	
		Control Inputs	–0.5	6.5	
V_O	Voltage applied to any output in the high-impedance or power-off state(2)	A Port	–0.5	6.5	V
		B Port	–0.5	6.5	
V_O	Voltage applied to any output in the high or low state(2) (3)	A Port	–0.5	V_{CCA} + 0.5	V
		B Port	–0.5	V_{CCB} + 0.5	
I_{IK}	Input clamp current	V_I < 0	–50		mA
I_{OK}	Output clamp current	V_O < 0	–50		mA
I_O	Continuous output current		–50	50	mA
	Continuous current through V_{CC} or GND		–200	200	mA
T_j	Junction Temperature			150	°C
T_{stg}	Storage temperature		–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure beyond the limits listed in *Recommended Operating Conditions* may affect device reliability.
(2) The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) The output positive-voltage rating may be exceeded up to 6.5 V maximum if the output current rating is observed.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002(1)	±4000	V
		Charged device model (CDM), per AEC Q100-011	±1000	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

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6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1) (2) (3)

				MIN	MAX	UNIT
V_{CCA}	Supply voltage A			1.08	5.5	V
V_{CCB}	Supply voltage B			1.08	5.5	V
I_{OH}	High-level output current		V_{CCO} = 1.1 V		–0.1	mA
			V_{CCO} = 1.4 V		–4	
			V_{CCO} = 1.65 V		–8	
			V_{CCO} = 2.3 V		–12	
			V_{CCO} = 3 V		–24	
			V_{CCO} = 4.5 V		–32	
I_{OL}	Low-level output current		V_{CCO} = 1.1 V		0.1	mA
			V_{CCO} = 1.4 V		4	
			V_{CCO} = 1.65 V		8	
			V_{CCO} = 2.3 V		12	
			V_{CCO} = 3 V		24	
			V_{CCO} = 4.5 V		32	
V_I	Input voltage (3)			0	5.5	V
V_O	Output voltage	Active State		0	V_{CCO}	V
		Tri-State		0	5.5	
T_A	Operating free-air temperature			–40	125	°C

(1) V_{CCI} is the V_{CC} associated with the input port.
(2) V_{CCO} is the V_{CC} associated with the output port.
(3) All control inputs and data I/Os of this device have weak pulldowns so that the line is not floating when undefined external to the device. The input leakage from these weak pulldowns is defined by the I_I specification indicated under *Electrical Characteristics*.

6.4 Thermal Information

THERMAL METRIC(1)		SN74LXC8T245				UNIT
		PW (TSSOP)	RHL (VQFN)	DGS (VSSOP)	RJW (UQFN)	
		24 PINS	24 PINS	24 PINS	24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	99.6	47.4	86.2	118.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	43.7	42.6	34.6	61.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	54.7	25.1	47.2	49.9	°C/W
Y_{JT}	Junction-to-top characterization parameter	6.4	2.7	1.5	3.3	°C/W
Y_{JB}	Junction-to-board characterization parameter	54.3	25.1	46.9	49.7	°C/W
$R_{\theta JC(bottom)}$	Junction-to-case (bottom) thermal resistance	n/a	14.9	n/a	n/a	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)									UNIT
					25°C			–40°C to 85°C			–40°C to 125°C			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{T+}	Positive-going input-threshold voltage	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.1 V	1.1 V				0.44		0.88	0.44		0.88	V
			1.4 V	1.4 V				0.60		0.98	0.60		0.98	
			1.65 V	1.65 V				0.76		1.13	0.76		1.13	
			2.3 V	2.3 V				1.08		1.56	1.08		1.56	
			3 V	3 V				1.48		1.92	1.48		1.92	
			4.5 V	4.5 V				2.19		2.74	2.19		2.74	
			5.5 V	5.5 V				2.65		3.33	2.65		3.33	
		Control Inputs ($\overline{OE}$, DIR) (Referenced to V_{CCA})	1.1 V	1.1 V				0.44		0.88	0.44		0.88	V
			1.4 V	1.4 V				0.60		0.98	0.60		0.98	
			1.65 V	1.65 V				0.76		1.13	0.76		1.13	
			2.3 V	2.3 V				1.08		1.56	1.08		1.56	
			3 V	3 V				1.48		1.92	1.48		1.92	
			4.5 V	4.5 V				2.19		2.74	2.19		2.74	
			5.5 V	5.5 V				2.65		3.33	2.65		3.33	
V_{T-}	Negative-going input-threshold voltage	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.1 V	1.1 V				0.17		0.48	0.17		0.48	V
			1.4 V	1.4 V				0.28		0.59	0.28		0.59	
			1.65 V	1.65 V				0.35		0.69	0.35		0.69	
			2.3 V	2.3 V				0.56		0.97	0.56		0.97	
			3 V	3 V				0.89		1.5	0.89		1.5	
			4.5 V	4.5 V				1.51		1.97	1.51		1.97	
			5.5 V	5.5 V				1.88		2.4	1.88		2.4	
		Control Inputs ($\overline{OE}$, DIR) (Referenced to V_{CCA})	1.1 V	1.1 V				0.17		0.48	0.17		0.48	V
			1.4 V	1.4 V				0.28		0.6	0.28		0.6	
			1.65 V	1.65 V				0.35		0.71	0.35		0.71	
			2.3 V	2.3 V				0.56		1	0.56		1	
			3 V	3 V				0.89		1.5	0.89		1.5	
			4.5 V	4.5 V				1.51		2	1.51		2	
			5.5 V	5.5 V				1.88		2.46	1.88		2.46	
ΔV_T	Input-threshold hysteresis ($V_{T+} - V_{T-}$)	Data Inputs (Ax, Bx) (Referenced to V_{CCI})	1.1 V	1.1 V				0.2		0.4	0.2		0.4	V
			1.4 V	1.4 V				0.25		0.5	0.25		0.5	
			1.65 V	1.65 V				0.3		0.55	0.3		0.55	
			2.3 V	2.3 V				0.38		0.65	0.38		0.65	
			3 V	3 V				0.46		0.72	0.46		0.72	
			4.5 V	4.5 V				0.58		0.93	0.58		0.93	
			5.5 V	5.5 V				0.69		1.06	0.69		1.06	
		Control Inputs ($\overline{OE}$, DIR) (Referenced to V_{CCA})	1.1 V	1.1 V				0.2		0.4	0.2		0.4	V
			1.4 V	1.4 V				0.25		0.5	0.25		0.5	
			1.65 V	1.65 V				0.3		0.55	0.3		0.55	
			2.3 V	2.3 V				0.38		0.65	0.38		0.65	
			3 V	3 V				0.46		0.72	0.46		0.72	
			4.5 V	4.5 V				0.58		0.93	0.58		0.93	
			5.5 V	5.5 V				0.69		1.06	0.69		1.06	

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6.5 Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)									UNIT
					25°C			–40°C to 85°C			–40°C to 125°C			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{OH}	High-level output voltage (3)	I_{OH} = –100 µA	1.1 V - 5.5 V	1.1 V - 5.5 V				V_{CCO} – 0.1			V_{CCO} – 0.1			V
		I_{OH} = –4 mA	1.4 V	1.4 V				1			1			
		I_{OH} = –8 mA	1.65 V	1.65 V				1.2			1.2			
		I_{OH} = –12 mA	2.3 V	2.3 V				1.9			1.9			
		I_{OH} = –24 mA	3 V	3 V				2.4			2.4			
		I_{OH} = –32 mA	4.5 V	4.5 V				3.8			3.8			
V_{OL}	Low-level output voltage (4)	I_{OL} = 100 µA	1.1 V - 5.5 V	1.1 V - 5.5 V						0.1			0.1	V
		I_{OL} = 4 mA	1.4 V	1.4 V						0.3			0.3	
		I_{OL} = 8 mA	1.65 V	1.65 V						0.45			0.45	
		I_{OL} = 12 mA	2.3 V	2.3 V						0.3			0.3	
		I_{OL} = 24 mA	3 V	3 V						0.55			0.55	
		I_{OL} = 32 mA	4.5 V	4.5 V						0.55			0.55	
I_I	Input leakage current	Control inputs (DIR, $\overline{OE}$) V_I = V_{CCA} or GND	1.1 V - 5.5 V	1.1 V - 5.5 V	-0.1		1.5	-0.1		2	-0.1		2	µA
		Data Inputs (Ax, Bx) V_I = V_{CCI} or GND	1.1 V - 5.5 V	1.1 V - 5.5 V	–0.3		0.3	–1		1	–2		2	µA
I_{off}	Partial power down current	A Port or B Port V_I or V_O = 0 V - 5.5 V	0 V	0 V - 5.5 V	–1.5		1.5	–2		2	–2.5		2.5	µA
			0 V - 5.5 V	0 V	–1.5		1.5	–2		2	–2.5		2.5	
$I_{off-float}$	Floating supply Partial power down current	A Port or B Port V_I or V_O = GND	Floating (6)	0 V - 5.5 V	–1.5		1.5	–2		2	–2.5		2.5	µA
			0 V - 5.5 V	Floating (6)	–1.5		1.5	–2		2	–2.5		2.5	
I_{OZ}	Tri-state output current (5)	A or B Port: V_I = V_{CCI} or GND V_O = V_{CCO} or GND $\overline{OE}$ = $V_{T+(MAX)}$	1.1 V - 5.5 V	1.1 V - 5.5 V	–0.3		0.3	–1		1	–2		2	µA
I_{CCA}	V_{CCA} supply current	V_I = V_{CCI} or GND I_O = 0	1.1 V - 5.5 V	1.1 V - 5.5 V			2			4			8	µA
			0 V	5.5 V	–0.2			–0.5			–1			
			5.5 V	0 V			1			2			4	
		V_I = GND I_O = 0	5.5 V	Floating (6)			2			4			8	
I_{CCB}	V_{CCB} supply current	V_I = V_{CCI} or GND I_O = 0	1.1 V - 5.5 V	1.1 V - 5.5 V			2			4			8	µA
			0 V	5.5 V			1			2			4	
			5.5 V	0 V	–0.2			–0.5			–1			
		V_I = GND I_O = 0	Floating (6)	5.5 V			2			4			8	
I_{CCA} + I_{CCB}	Combined supply current	V_I = V_{CCI} or GND I_O = 0	1.1 V - 5.5 V	1.1 V - 5.5 V			4			8			12	µA

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6.5 Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)(1) (2)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)									UNIT
					25°C			–40°C to 85°C			–40°C to 125°C			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
ΔI_{CCA}	V_{CCA} additional supply current per input	Control inputs (DIR, $\overline{OE}$): $V_I = V_{CCA} - 0.6$ V A port = VCCA or GND B Port = open	3.0 V - 5.5 V	3.0 V - 5.5 V						50			75	µA
		A Port: $V_I = V_{CCA} - 0.6$ V DIR = V_{CCA}, B Port = open	3.0 V - 5.5 V	3.0 V - 5.5 V						50			75	
ΔI_{CCB}	V_{CCB} additional supply current per input	B Port: $V_I = V_{CCB} - 0.6$ V DIR = GND, A Port = open	3.0 V - 5.5 V	3.0 V - 5.5 V						50			75	µA
C_i	Control Input Capacitance	V_I = 3.3 V or GND	3.3 V	3.3 V		2.6				5			5	pF
C_{io}	Data I/O Capacitance	$\overline{OE} = V_{CCA}$, V_O = 1.65V DC +1 MHz -16 dBm sine wave	3.3 V	3.3 V		5.8				10			10	pF

(1) V_{CCI} is the V_{CC} associated with the input port.
(2) V_{CCO} is the V_{CC} associated with the output port.
(3) Tested at $V_I = V_{T+(MAX)}$.
(4) Tested at $V_I = V_{T-(MIN)}$.
(5) For I/O ports, the parameter I_{OZ} includes the input leakage current.
(6) Floating is defined as a node that is both not actively driven by an external device and has leakage not exeeding 10 nA.

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6.6 Switching Characteristics, V_{CCA} = 1.2 ± 0.1 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B-PORT SUPPLY VOLTAGE (V_{CCB})																		UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	10		65	10		31	7		25	7		24	5		22	5		21	ns
				–40°C to 125°C	10		70	10		33	7		27	7		26	5		24	5		23	
		B	A	–40°C to 85°C	10		62	10		55	10		49	8		42	8		40	8		39	
				–40°C to 125°C	10		68	10		60	10		54	8		47	8		45	8		44	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	20		64	20		64	20		64	20		64	20		64	20		64	ns
				–40°C to 125°C	20		69	20		69	20		69	20		69	20		69	20		69	
		$\overline{OE}$	B	–40°C to 85°C	20		80	20		62	20		54	20		48	20		47	20		45	
				–40°C to 125°C	20		85	20		67	20		59	20		52	20		50	20		48	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	20		90	20		91	20		91	20		91	20		90	20		90	ns
				–40°C to 125°C	20		97	20		98	20		97	20		96	20		96	20		96	
		$\overline{OE}$	B	–40°C to 85°C	20		95	20		57	15		48	10		38	10		36	10		36	
				–40°C to 125°C	20		100	20		61	15		53	10		42	10		39	10		39	

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6.7 Switching Characteristics, V_{CCA} = 1.5 ± 0.1 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B–PORT SUPPLY VOLTAGE (V_{CCB})																		UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	10		52	5		25	5		23	5		17	5		14	3		13	ns
				–40°C to 125°C	10		57	5		26	5		23	5		18	5		16	3		14	
		B	A	–40°C to 85°C	8		36	7		28	7		26	5		20	5		18	5		17	
				–40°C to 125°C	8		40	7		29	7		26	5		22	5		20	5		18	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	15		40	15		40	15		40	15		40	15		40	15		40	ns
				–40°C to 125°C	15		44	15		44	15		44	15		44	15		44	15		44	
		$\overline{OE}$	B	–40°C to 85°C	20		69	20		50	15		45	15		35	15		34	14		31	
				–40°C to 125°C	20		74	20		54	15		48	15		39	15		37	14		33	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	15		48	15		48	15		48	15		48	15		48	15		48	ns
				–40°C to 125°C	15		52	15		52	15		52	15		52	15		52	15		52	
		$\overline{OE}$	B	–40°C to 85°C	20		85	15		50	15		40	10		31	10		26	10		24	
				–40°C to 125°C	20		91	15		54	15		44	10		33	10		29	10		26	

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6.8 Switching Characteristics, V_{CCA} = 1.8 ± 0.15 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B–PORT SUPPLY VOLTAGE (V_{CCB})																		UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	8		50	6		21	6		18	4		14	4		11	2		10	ns
				–40°C to 125°C	8		53	6		23	6		20	4		15	4		12	2		11	
		B	A	–40°C to 85°C	5		32	5		21	5		19	4		17	4		15	4		15	
				–40°C to 125°C	5		33	5		23	5		21	4		18	4		16	4		16	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	10		34	10		33	10		33	10		33	10		33	10		33	ns
				–40°C to 125°C	10		36	10		35	10		35	10		35	10		35	10		35	
		$\overline{OE}$	B	–40°C to 85°C	20		64	15		45	15		40	12		31	12		31	10		26	
				–40°C to 125°C	20		69	15		49	15		44	12		33	12		38	10		28	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	10		38	10		38	10		38	10		38	10		38	10		38	ns
				–40°C to 125°C	10		40	10		40	10		40	10		40	10		40	10		40	
		$\overline{OE}$	B	–40°C to 85°C	20		84	15		47	10		38	10		29	10		25	8		23	
				–40°C to 125°C	20		89	15		51	10		42	10		30	10		26	8		25	

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6.9 Switching Characteristics, V_{CCA} = 2.5 ± 0.2 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B–PORT SUPPLY VOLTAGEe (V_{CCB})																		UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	7		40	5		21	4		16	3		12	3		10	3		8	ns
				–40°C to 125°C	7		45	5		22	4		17	3		13	3		11	3		9	
		B	A	–40°C to 85°C	5		26	5		16	5		15	4		12	3		11	3		10	
				–40°C to 125°C	5		28	5		17	5		15	4		13	3		12	3		11	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	10		24	10		24	10		24	10		24	10		22	10		24	ns
				–40°C to 125°C	10		26	10		26	10		24	10		24	10		24	10		24	
		$\overline{OE}$	B	–40°C to 85°C	15		56	15		41	12		34	12		25	10		24	10		21	
				–40°C to 125°C	15		62	15		44	12		37	12		29	10		26	10		22	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	8		25	8		25	8		25	8		25	8		25	8		25	ns
				–40°C to 125°C	8		27	8		27	8		27	8		27	8		27	8		27	
		$\overline{OE}$	B	–40°C to 85°C	20		80	15		46	10		34	10		25	5		23	5		18	
				–40°C to 125°C	20		86	15		48	10		37	10		27	5		25	5		20	

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6.10 Switching Characteristics, V_{CCA} = 3.3 ± 0.3 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B–PORT SUPPLY VOLTAGE (V_{CCB})																		UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	8		41	6		19	4		15	3		10	3		9	2		6.5	ns
				–40°C to 125°C	8		43	6		21	4		16	3		11	3		10	2		7.5	
		B	A	–40°C to 85°C	5		22	5		15	4		12	3		10	3		9	3		8.5	
				–40°C to 125°C	5		24	5		16	4		13	3		11	3		10	3		9	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	9		19	9		19	9		19	8		19	8		19	8		19	ns
				–40°C to 125°C	9		20	9		20	9		20	8		20	8		20	8		20	
		$\overline{OE}$	B	–40°C to 85°C	15		52	15		38	12		32	10		23	10		22	9		18	
				–40°C to 125°C	15		59	15		41	12		35	10		26	10		23	9		20	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	5		20	5		20	5		20	5		20	5		20	5		20	ns
				–40°C to 125°C	5		22	5		22	5		22	5		22	5		22	5		22	
		$\overline{OE}$	B	–40°C to 85°C	20		80	15		43	10		34	5		24	5		19	5		16	
				–40°C to 125°C	20		85	15		46	10		36	5		27	5		21	5		18	

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6.11 Switching Characteristics, V_{CCA} = 5.0 ± 0.5 V

See Figure 7-1 and Table 7-1 for test circuit and loading. See Figure 7-2, Figure 7-3, and Figure 7-4 for measurement waveforms.

PARAMETER		FROM	TO	TEST CONDITIONS	B–PORT SUPPLY VOLTAGE (V_{CCB})														UNIT
					1.2 ± 0.1 V			1.5 ± 0.1 V			1.8 ± 0.15 V			2.5 ± 0.2 V			3.3 ± 0.3 V			5.0 ± 0.5 V			
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_{pd}	Propagation delay	A	B	–40°C to 85°C	8		38	6		15	3		14	3		9.5	2		8	2		6	ns
				–40°C to 125°C	8		42	6		17	3		15	3		10.5	2		8.5	2		7	
		B	A	–40°C to 85°C	5		22	4		13	3		10.5	3		8	2		7.5	2		7	
				–40°C to 125°C	5		24	4		15	3		11.5	3		8.5	2		8	2		7.5	
t_{dis}	Disable time	$\overline{OE}$	A	–40°C to 85°C	7		15	5		15	5		15	5		15	5		14	5		14	ns
				–40°C to 125°C	7		16	5		16	5		16	5		16	5		15	5		15	
		$\overline{OE}$	B	–40°C to 85°C	15		52	12		33	10		31	10		22	10		21	5		16	
				–40°C to 125°C	15		56	12		37	10		35	10		24	10		23	5		18	
t_{en}	Enable time	$\overline{OE}$	A	–40°C to 85°C	5		15	5		15	5		15	5		15	5		15	5		15	ns
				–40°C to 125°C	5		16	5		16	5		16	5		16	5		16	5		16	
		$\overline{OE}$	B	–40°C to 85°C	20		80	15		44	10		33	5		24	5		18	5		15	
				–40°C to 125°C	20		85	15		48	10		35	5		26	5		20	5		17	

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6.12 Switching Characteristics: T_{sk}, T_{MAX}

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V_{CCI}	V_{CCO}	Operating temp (T_A) -40°C to 125°C			UNIT
					MIN	TYP	MAX	
T_{MAX} - Maximum Data Rate	50% Duty Cycle Input One channel switching 20% of pulse > 0.7*V_{CCO} 20% of pulse < 0.3*V_{CCO}	Up Translation	3.0 V – 3.6 V	4.5 V – 5.5 V	200	420		Mbps
			1.65 V – 1.95 V	4.5 V – 5.5 V	100	200		
			1.1 V – 1.3 V	4.5 V – 5.5 V	20	40		
			1.65 V – 1.95 V	3.0 V – 3.6 V	100	210		
			1.1 V – 1.3 V	3.0 V – 3.6 V	10	20		
			1.1 V – 1.3 V	1.65 V – 1.95 V	5	10		
		Down Translation	4.5 V – 5.5 V	3.0 V – 3.6 V	100	210		
			4.5 V – 5.5 V	1.65 V – 1.95 V	50	75		
			4.5 V – 5.5 V	1.1 V – 1.3 V	15	30		
			3.0 V – 3.6 V	1.65 V – 1.95 V	40	75		
			3.0 V – 3.6 V	1.1 V – 1.3 V	10	20		
			1.65 V – 1.95 V	1.1 V – 1.3 V	5	10		
t_{sk} - Output skew	Timing skew between any two switching outputs within the same device	Up Translation	3.0 V – 3.6 V	4.5 V – 5.5 V			0.5	ns
			1.65 V – 1.95 V	4.5 V – 5.5 V			1	
			1.1 V – 1.3 V	4.5 V – 5.5 V			1.5	
			1.65 V – 1.95 V	3.0 V – 3.6 V			1	
			1.1 V – 1.3 V	3.0 V – 3.6 V			1.5	
			1.1 V – 1.3 V	1.65 V – 1.95 V			2	
		Down Translation	4.5 V – 5.5 V	3.0 V – 3.6 V			0.5	
			4.5 V – 5.5 V	1.65 V – 1.95 V			1	
			4.5 V – 5.5 V	1.1 V – 1.3 V			1.5	
			3.0 V – 3.6 V	1.65 V – 1.95 V			1	
			3.0 V – 3.6 V	1.1 V – 1.3 V			1.5	
			1.65 V – 1.95 V	1.1 V – 1.3 V			2	

6.13 Operating Characteristics

T_A = 25°C (1)

PARAMETER		Test Conditions	Supply Voltage (V_{CCB} = V_{CCA}) 1.2 ± 0.1V TYP	1.5 ± 0.1V TYP	1.8 ± 0.15V TYP	2.5 ± 0.2V TYP	3.3 ± 0.3V TYP	5.0 ± 0.5V TYP	UNIT
C_{pdA} (2)	A to B: outputs enabled	A Port CL = 0, RL = Open f = 10 MHz t_{rise} = t_{fall} = 1 ns	2	2	2	2	2	3	pF
	A to B: outputs disabled		2	2	2	2	2	3	
	B to A: outputs enabled		12	12	12	13	13	16	
	B to A: outputs disabled		2	2	2	2	2	3	
C_{pdB} (2)	A to B: outputs enabled	B Port CL = 0, RL = Open f = 10 MHz t_{rise} = t_{fall} = 1 ns	12	12	12	13	13	16	pF
	A to B: outputs disabled		2	2	2	2	2	3	
	B to A: outputs enabled		2	2	2	2	2	3	
	B to A: outputs disabled		2	2	2	2	2	3	

(1) For more information about power dissipation capacitance, see the *CMOS Power Consumption and C_{pd} Calculation* application report.
(2) C_{pdA} and C_{pdB} are repectively A-Port and B-Port power dissipation capacitances per transceiver.

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6.14 Typical Characteristics

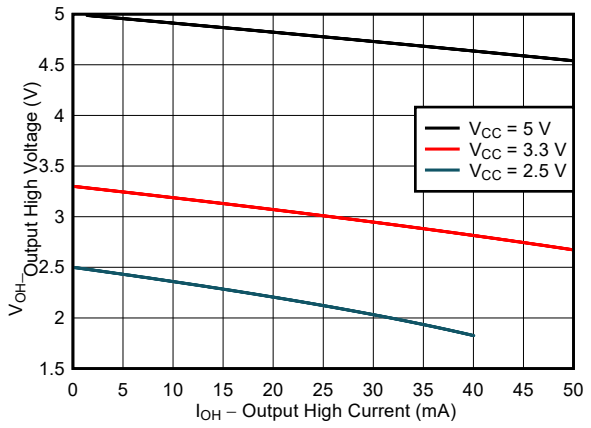


Figure 6-1. Typical (T_A=25°C) Output High Voltage (V_{OH}) vs Source Current (I_{OH})

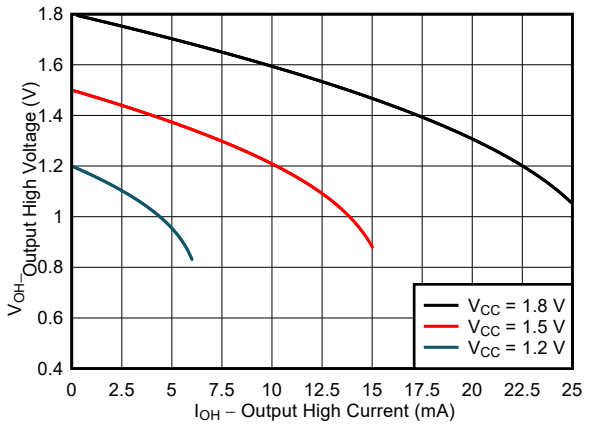


Figure 6-2. Typical (T_A=25°C) Output High Voltage (V_{OH}) vs Source Current (I_{OH})

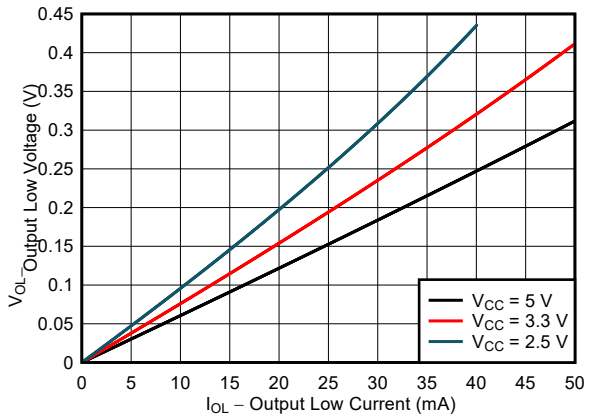


Figure 6-3. Typical (T_A=25°C) Output Low Voltage (V_{OL}) vs Sink Current (I_{OL})

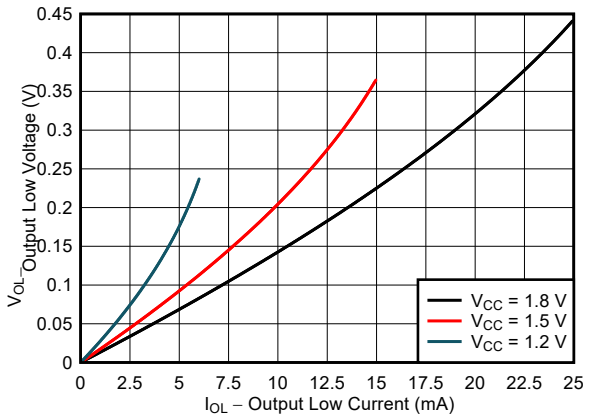


Figure 6-4. Typical (T_A=25°C) Output Low Voltage (V_{OL}) vs Sink Current (I_{OL})

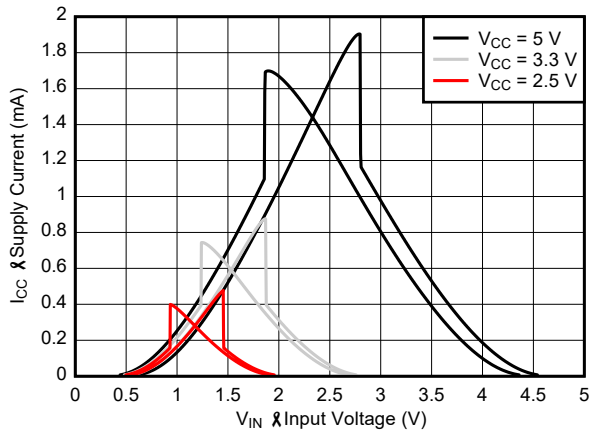


Figure 6-5. Typical (T_A=25°C) Supply Current (I_{CC}) vs Input Voltage (V_{IN})

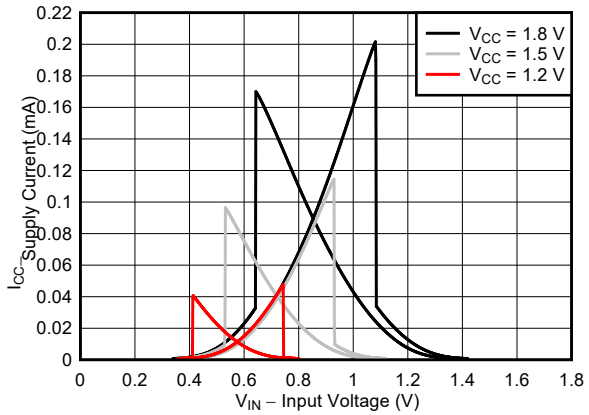


Figure 6-6. Typical (T_A=25°C) Supply Current (I_{CC}) vs Input Voltage (V_{IN})

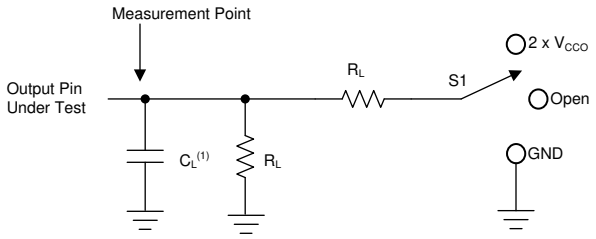
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7 Parameter Measurement Information

7.1 Load Circuit and Voltage Waveforms

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- f = 1 MHz
- Z_O = 50 Ω
- Δt/ΔV ≤ 1 ns/V

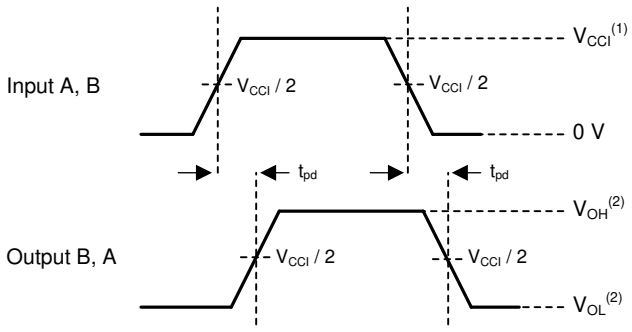


1. C_L includes probe and jig capacitance.

Figure 7-1. Load Circuit

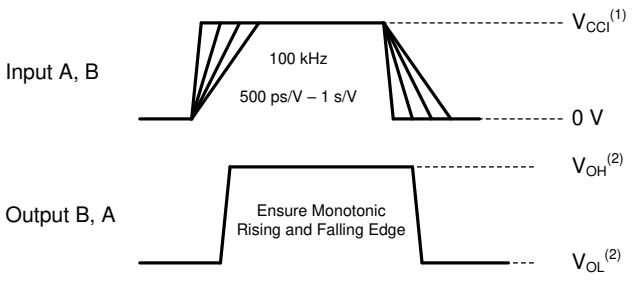
Table 7-1. Load Circuit Conditions

Parameter		V_{CCO}	R_L	C_L	S_1	V_{TP}
t_{pd}	Propagation (delay) time	1.1 V – 5.5 V	2 kΩ	15 pF	Open	N/A
t_{en}, t_{dis}	Enable time, disable time	1.1 V – 1.6 V	2 kΩ	15 pF	2 × V_{CCO}	0.1 V
		1.65 V – 2.7 V	2 kΩ	15 pF	2 × V_{CCO}	0.15 V
		3.0 V – 5.5 V	2 kΩ	15 pF	2 × V_{CCO}	0.3 V
t_{en}, t_{dis}	Enable time, disable time	1.1 V – 1.6 V	2 kΩ	15 pF	GND	0.1 V
		1.65 V – 2.7 V	2 kΩ	15 pF	GND	0.15 V
		3.0 V – 5.5 V	2 kΩ	15 pF	GND	0.3 V



1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

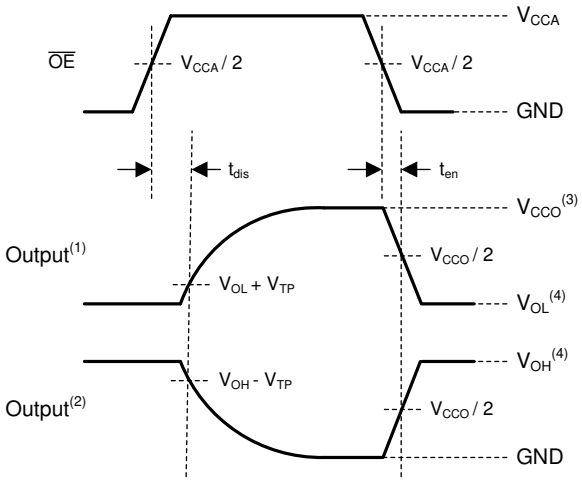
Figure 7-2. Propagation Delay



1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

Figure 7-3. Input Transition Rise and Fall Rate

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1. Output waveform on the condition that input is driven to a valid Logic Low.
2. Output waveform on the condition that input is driven to a valid Logic High.
3. V_{CCO} is the supply pin associated with the output port.
4. V_{OH} and V_{OL} are typical output voltage levels with specified R_L, C_L, and S_1.

Figure 7-4. Enable Time And Disable Time

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8 Detailed Description

8.1 Overview

The SN74LXC8T245-Q1 is an 8-bit translating transceiver that uses two individually configurable power-supply rails. The device is operational with both V_{CCA} and V_{CCB} supplies as low as 1.1 V and as high as 5.5 V. Additionally, the device can operate with V_{CCA} = V_{CCB}. The A port is designed to track V_{CCA}, and the B port is designed to track V_{CCB}.

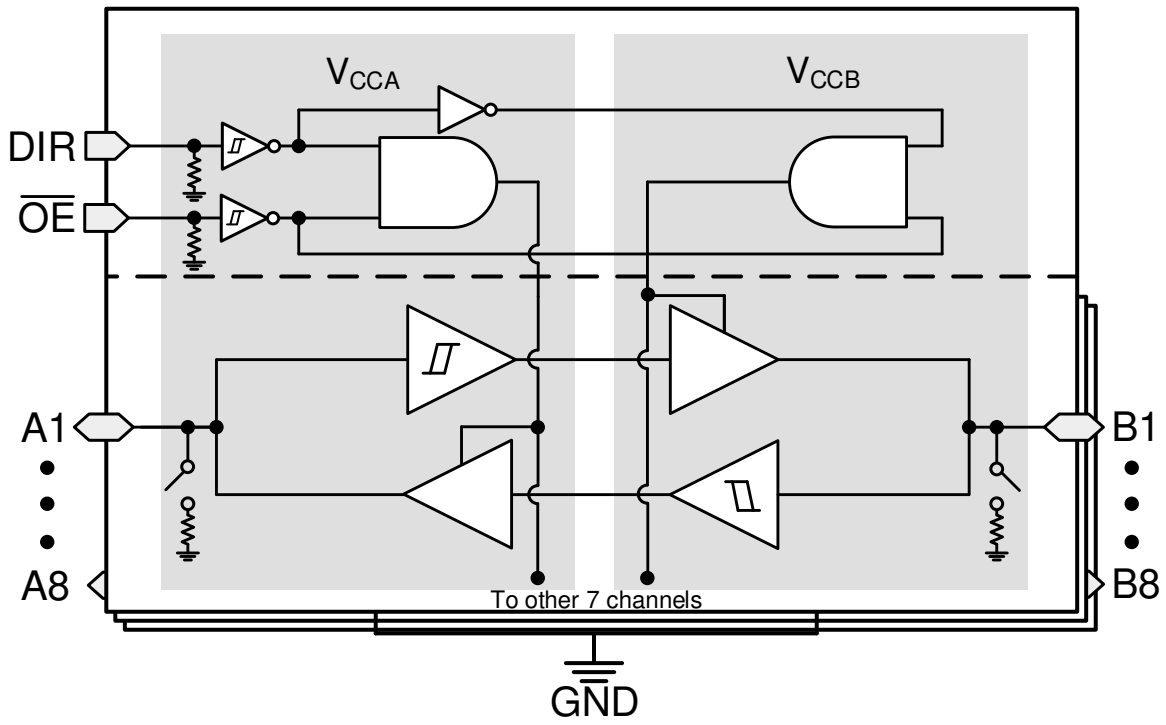
The SN74LXC8T245-Q1 device is designed for asynchronous communication between data buses, and transmits data from the A bus to the B bus or from the B bus to the A bus based on the logic level of the direction-control input (DIR). The output-enable input ($\overline{OE}$) is used to disable the outputs so the buses are effectively isolated. The control pins of the SN74LXC8T245-Q1 (DIR and $\overline{OE}$) are referenced to V_{CCA}. For the level shifter I/Os to be in the high-impedance state during power up or power down, the $\overline{OE}$ pin should be tied to V_{CCA} through a pullup resistor.

This device is fully specified for partial-power-down applications using the I_{off} current. The I_{off} protection circuitry is designed so that no excessive current is drawn from or sourced into an input, output, or I/O while the device is powered down.

The V_{CC} isolation or V_{CC} disconnect feature is designed so that if either V_{CC} is less than 100 mV or disconnected with the complementary supply within recommended operating conditions, both I/O ports are weakly pulled-down and then set to the high-impedance state by disabling their outputs while the supply current is maintained. The $I_{off-float}$ circuitry is designed so that no excessive current is drawn from or sourced into an input, output, or I/O while the supply is floating.

Glitch-free power supply sequencing allows either supply rail to be powered on or off in any order while providing robust power sequencing performance.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 CMOS Schmitt-Trigger Inputs with Integrated Pulldowns

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using ohm's law (R = V ÷ I).

The Schmitt-trigger input architecture provides hysteresis as defined by ΔV_T in the *Electrical Characteristics*, which makes this device extremely tolerant to slow or noisy inputs. Driving the inputs slowly will increase dynamic current consumption of the device. For additional information regarding Schmitt-trigger inputs, see the *Understanding Schmitt Triggers* application brief.

8.3.1.1 I/Os with Integrated Dynamic Pull-Down Resistors

Input circuits of the data I/Os are always active even when the device is disabled. It is recommended to keep a valid voltage level at the I/Os to avoid high current consumption. To help avoid floating inputs on the I/Os during disabling, this device has 100-kΩ typical integrated weak dynamic pull-downs on all data I/Os. When the device is disabled, the dynamic pull-downs are activated for only a short period of time to help drive and keep low any floating inputs before the device I/Os become high impedance. If the I/O lines will be floated after the device is disabled, then it is recommended to keep them at a valid input voltage level using external pull-downs. This feature is ideal for loads of 30 pF or less. If greater capactive loading is present, then external pull-downs are recommended. If an external pull-up is required, then it should be no larger than 15 kΩ to avoid contention with the 100 kΩ internal pull-down.

8.3.1.2 Control Inputs with Integrated Static Pull-Down Resistors

Similar to the data I/Os, floating control inputs can cause high current consumption. This device has integrated weak static pull-downs of 5-MΩ typical on the control inputs (DIR and $\overline{OE}$) to help avoid this concern. These pull-downs are always present. For example, if the DIR pin is left floating, then the B port will be configured as an input and the A port will be configured as an output.

8.3.2 Balanced High-Drive CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The high drive capability of this device creates fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

8.3.3 Partial Power Down (I_{off})

The inputs and outputs for this device enter a high-impedance state when the device is powered down, inhibiting current backflow into the device. The maximum leakage into or out of any input or output pin on the device is specified by I_{off} in the *Electrical Characteristics*.

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8.3.4 V_{CC} Isolation and V_{CC} Disconnect ($I_{off-float}$)

This device has *I/Os with Integrated Dynamic Pull-Down Resistors*. The I/Os will get pulled down and then enter a high-impedance state when either supply is < 100 mV or left floating (disconnected), while the other supply is still connected to the device. It is recommended that the I/Os for this device are not driven and kept at a logic low state prior to floating (disconnecting) either supply.

The maximum supply current is specified by I_{CCx}, while V_{CCx} is floating, in the *Electrical Characterstics*. The maximum leakage into or out of any input or output pin on the device is specified by $I_{off(float)}$ in the *Electrical Characteristics*.

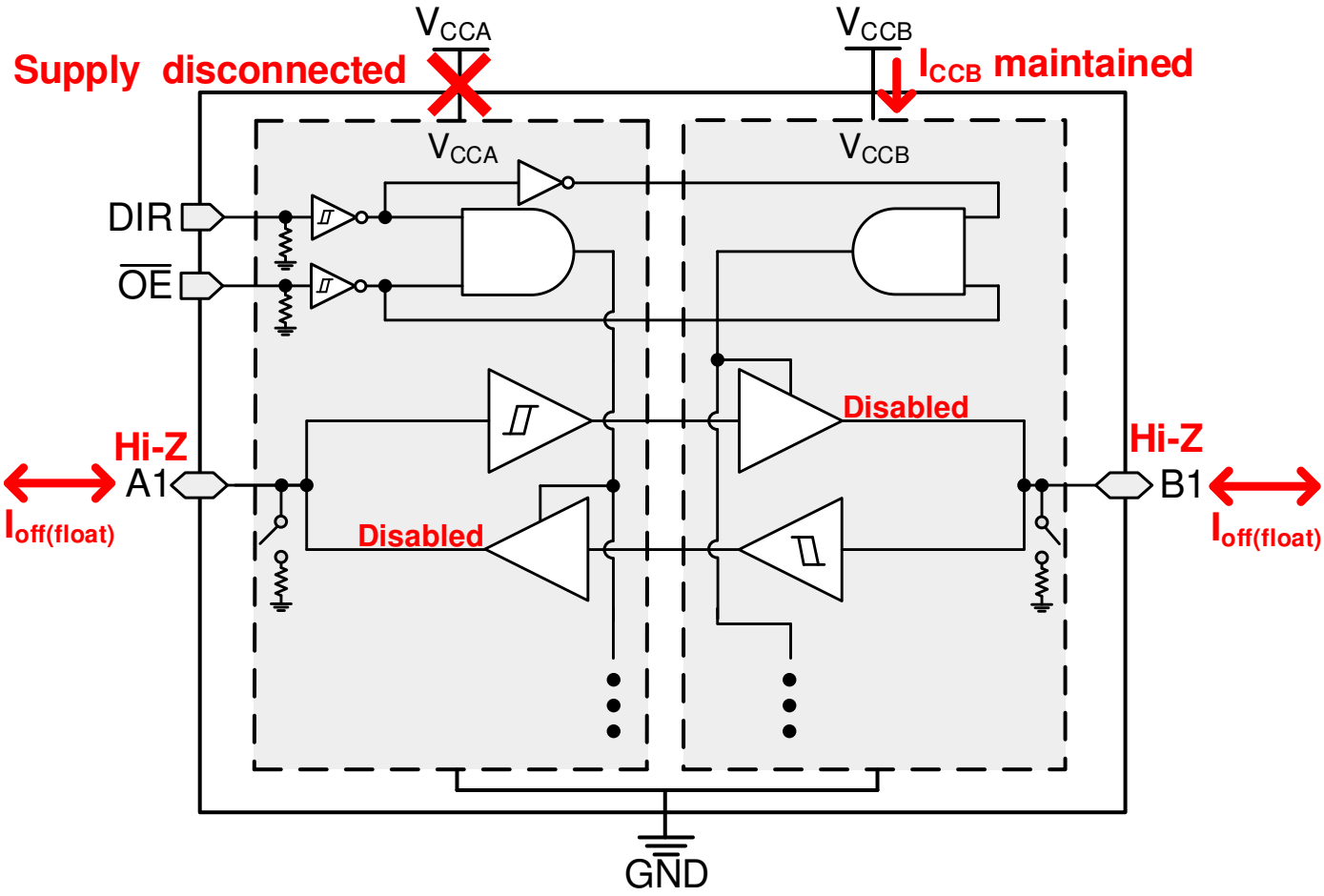


Figure 8-1. V_{CC} Disconnect Feature

8.3.5 Over-Voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the *Recommended Operating Conditions*.

8.3.6 Glitch-Free Power Supply Sequencing

Either supply rail may be powered on or off in any order without producing a glitch on the I/Os (that is, where the output erroneously transitions to VCC when it should be held low or vice versa). Glitches of this nature can be misinterpreted by a peripheral as a valid data bit, which could trigger a false device reset of the peripheral, a false device configuration of the peripheral, or even a false data initialization by the peripheral.

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8.3.7 Negative Clamping Diodes

Figure 8-2 shows how the inputs and outputs to this device have negative clamping diodes.

CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

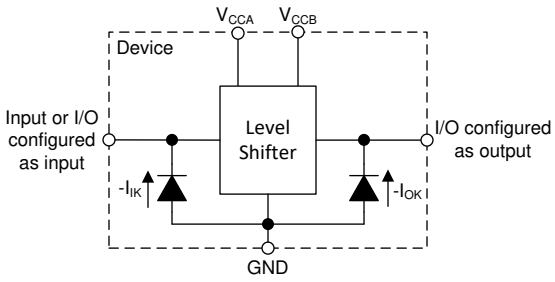


Figure 8-2. Electrical Placement of Clamping Diodes for Each Input and Output

8.3.8 Fully Configurable Dual-Rail Design

Both the V_{CCA} and V_{CCB} pins can be supplied at any voltage from 1.1 V to 5.5 V, making the device suitable for translating between any of the voltage nodes (1.2 V, 1.5 V, 1.8 V, 3.3 V, and 5.0 V).

8.3.9 Supports High-Speed Translation

The SN74LXC8T245-Q1 device can support high data-rate applications. The translated signal data rate can be up to 420 Mbps when the signal is translated from 3.3 V to 5.0 V.

8.4 Device Functional Modes

Table 8-1. Function Table

CONTROL INPUTS (1)		PORT STATUS		OPERATION
$\overline{OE}$	DIR	A PORT	B PORT	
L	L	Output (Enabled)	Input (Hi-Z)	B data to A bus
L	H	Input (Hi-Z)	Output (Enabled)	A data to B bus
H	X	Input (Hi-Z)	Input (Hi-Z)	Isolation

(1) Input circuits of the data I/Os are always active and should be kept at a valid logic level.

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9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74LXC8T245-Q1 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The SN74LXC8T245-Q1 device is ideal for use in applications where a push-pull driver is connected to the data I/Os. The maximum data rate can be up to 420 Mbps when device translates a signal from 3.3 V to 5.0 V.

9.2 Typical Application

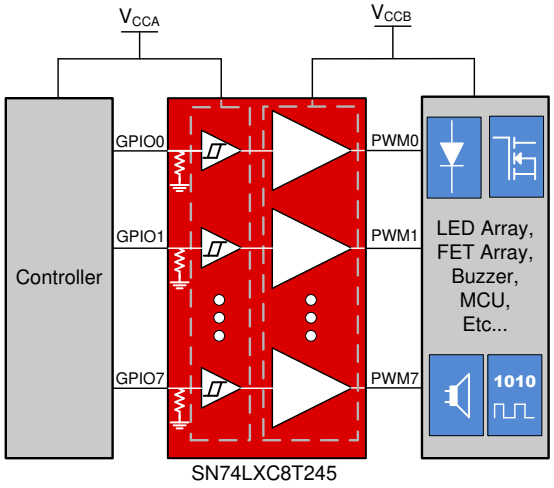


Figure 9-1. LED Driver Application

9.2.1 Design Requirements

For this design example, use the parameters listed in Table 9-1.

Table 9-1. Design Parameters

DESIGN PARAMETERS	EXAMPLE VALUES
Input voltage range	1.1 V to 5.5 V
Output voltage range	1.1 V to 5.5 V

9.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
  - Use the supply voltage of the device that is driving the SN74LXC8T245-Q1 device to determine the input voltage range. For a valid logic-high, the value must exceed the positive-going input-threshold voltage (V_{t+}) of the input port. For a valid logic low the value must be less than the negative-going input-threshold voltage (V_{t-}) of the input port.
- Output voltage range
  - Use the supply voltage of the device that the SN74LXC8T245-Q1 device is driving to determine the output voltage range.

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9.3 Power Supply Recommendations

Always apply a ground reference to the GND pins first. This device is designed for glitch free power sequencing without any supply sequencing requirements such as ramp order or ramp rate.

This device was designed with various power supply sequencing methods in mind to help prevent unintended triggering of downstream devices, as described in *Glitch-free Power Supply Sequencing*.

9.4 Layout

9.4.1 Layout Guidelines

For device reliability, following common printed-circuit board layout guidelines are recommended:

- Use bypass capacitors on the power supply pins and place them as close to the device as possible. A 0.1-µF capacitor is recommended, but transient performance can be improved by having both 1-µF and 0.1-µF capacitors in parallel as bypass capacitors.
- The high drive capability of this device creates fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

9.4.2 Layout Example

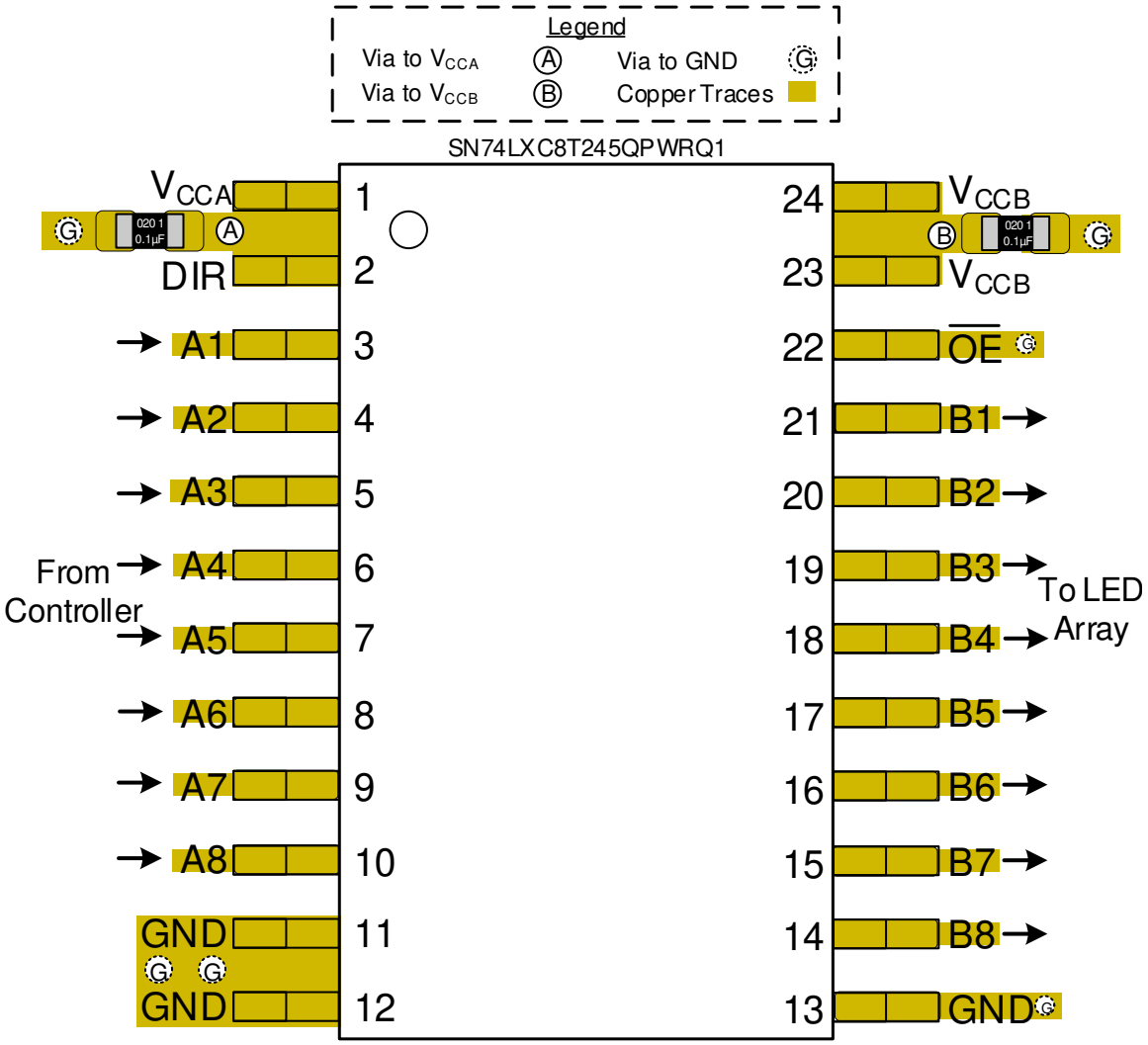


Figure 9-2. Layout Example – SN74LXC8T245PW-Q1

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10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *Understanding Schmitt Triggers* application report

10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CLXC8T245QDGSRQ1	Active	Production	VSSOP (DGS) | 24	5000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	L8245Q
CLXC8T245QDGSRQ1.A	Active	Production	VSSOP (DGS) | 24	5000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	L8245Q
CLXC8T245QRHLRQ1	Active	Production	VQFN (RHL) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LX8T245Q
CLXC8T245QRHLRQ1.A	Active	Production	VQFN (RHL) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LX8T245Q
SN74LXC8T245QPWRQ1	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LX8T245Q
SN74LXC8T245QPWRQ1.A	Active	Production	TSSOP (PW) | 24	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LX8T245Q

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LXC8T245-Q1 :

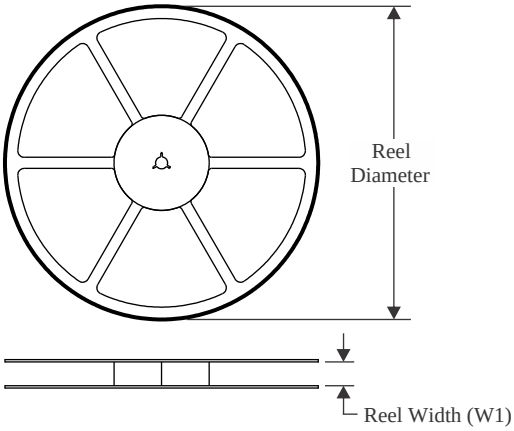
- Catalog : SN74LXC8T245

NOTE: Qualified Version Definitions:

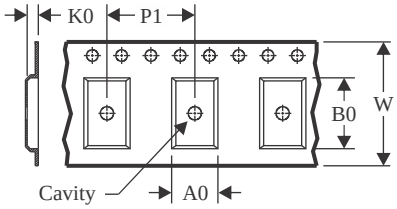
- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

REEL DIMENSIONS

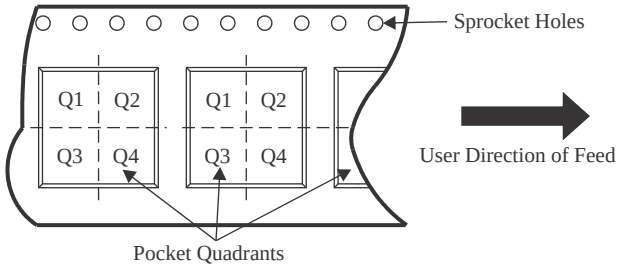


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

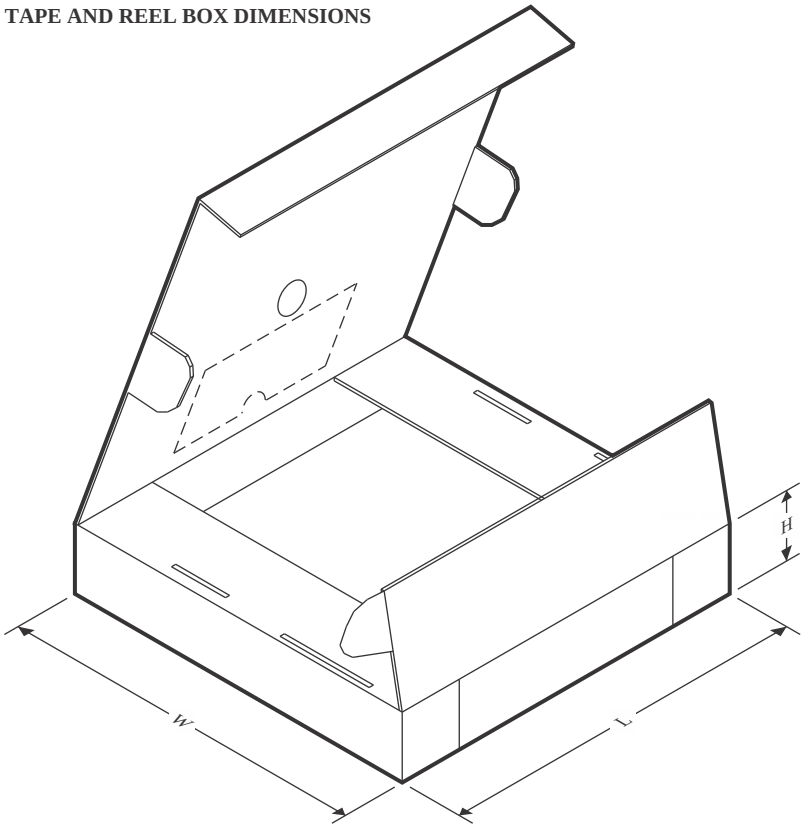
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

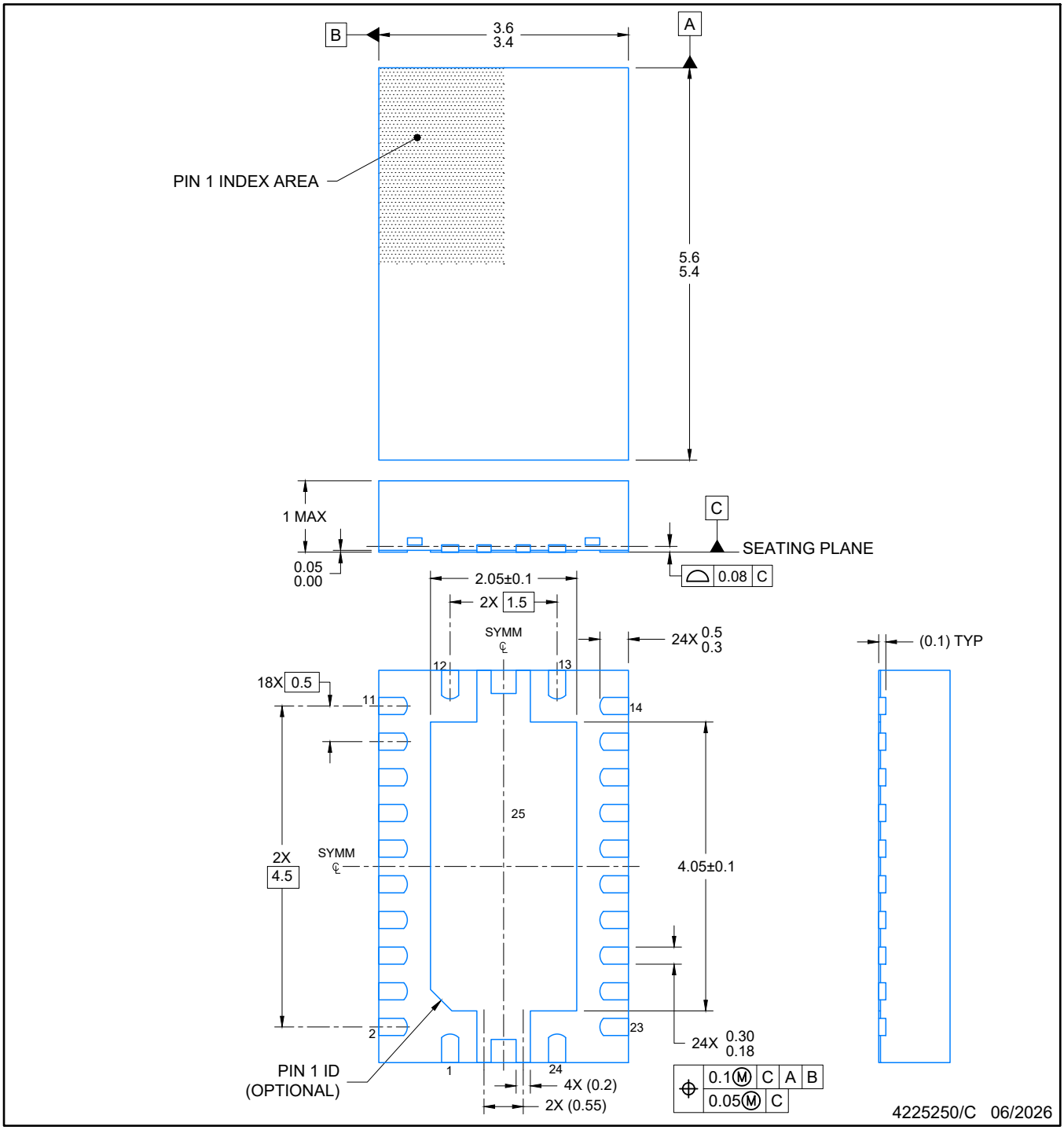
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CLXC8T245QRHLRQ1	VQFN	RHL	24	3000	330.0	12.4	3.8	5.8	1.2	8.0	12.0	Q1
SN74LXC8T245QPWRQ1	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



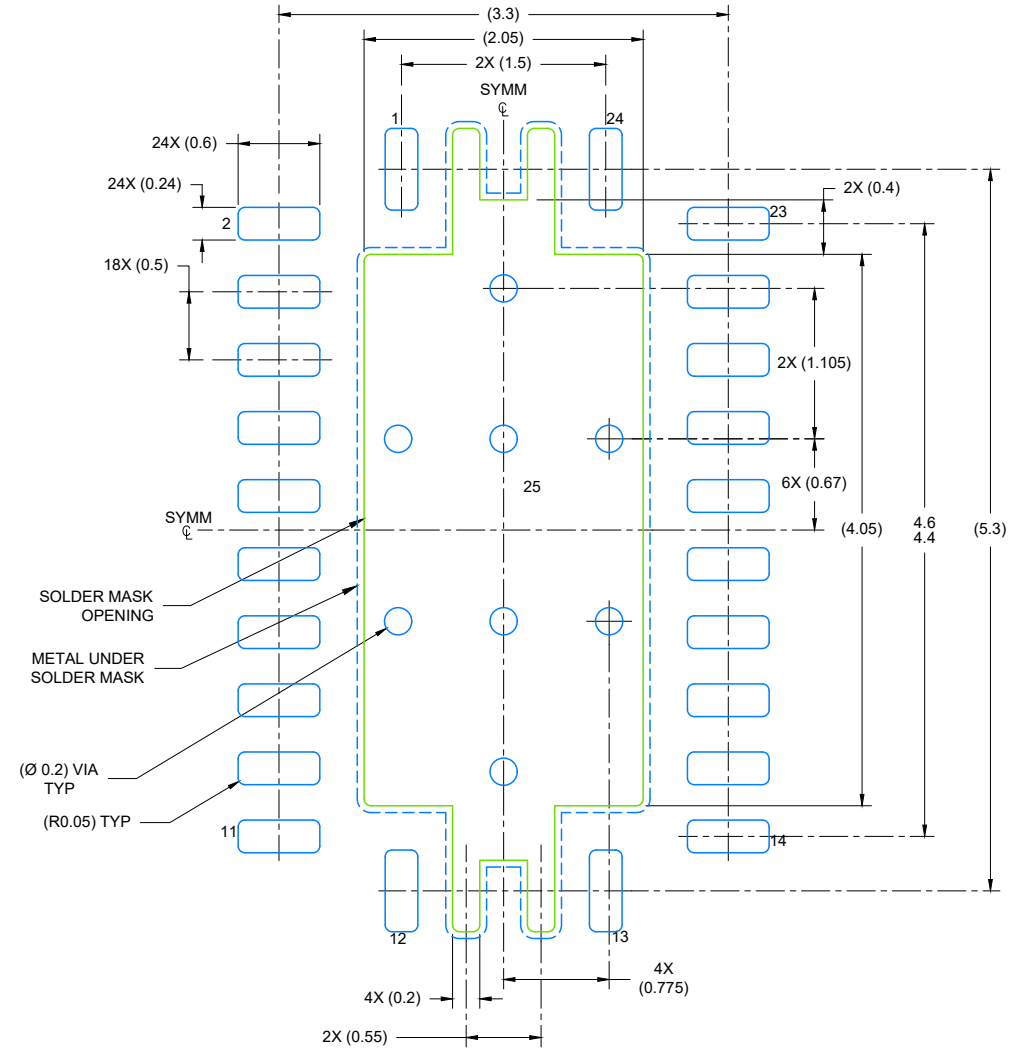
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CLXC8T245QRHLRQ1	VQFN	RHL	24	3000	367.0	367.0	35.0
SN74LXC8T245QPWRQ1	TSSOP	PW	24	2000	353.0	353.0	32.0

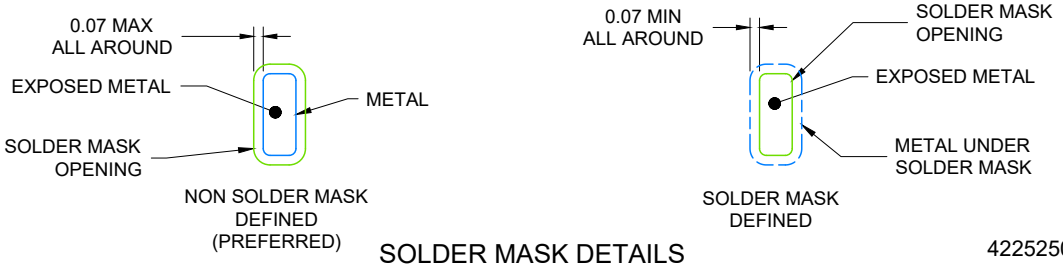


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 18X

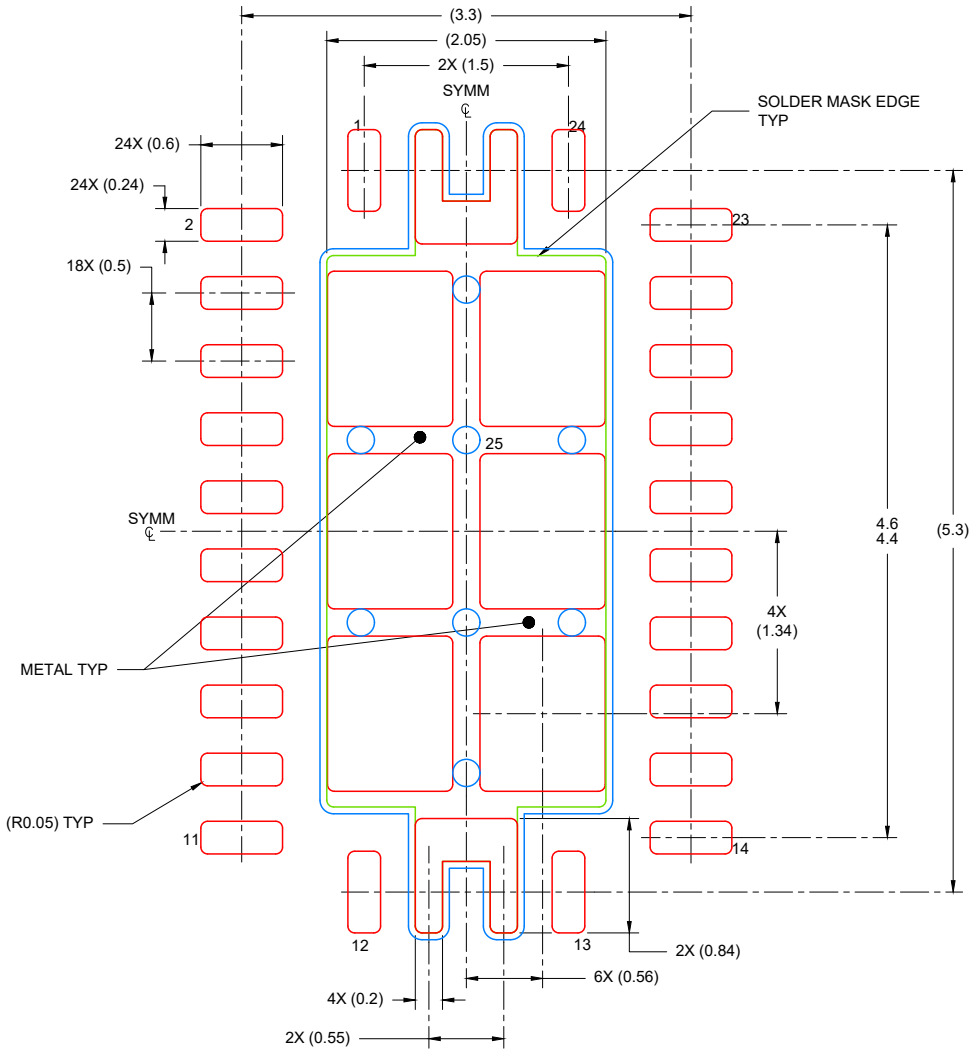


SOLDER MASK DETAILS

4225250/C 06/2026

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271) .
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
80% PRINTED COVERAGE BY AREA
SCALE: 18X

4225250/C 06/2026

NOTES: (continued)

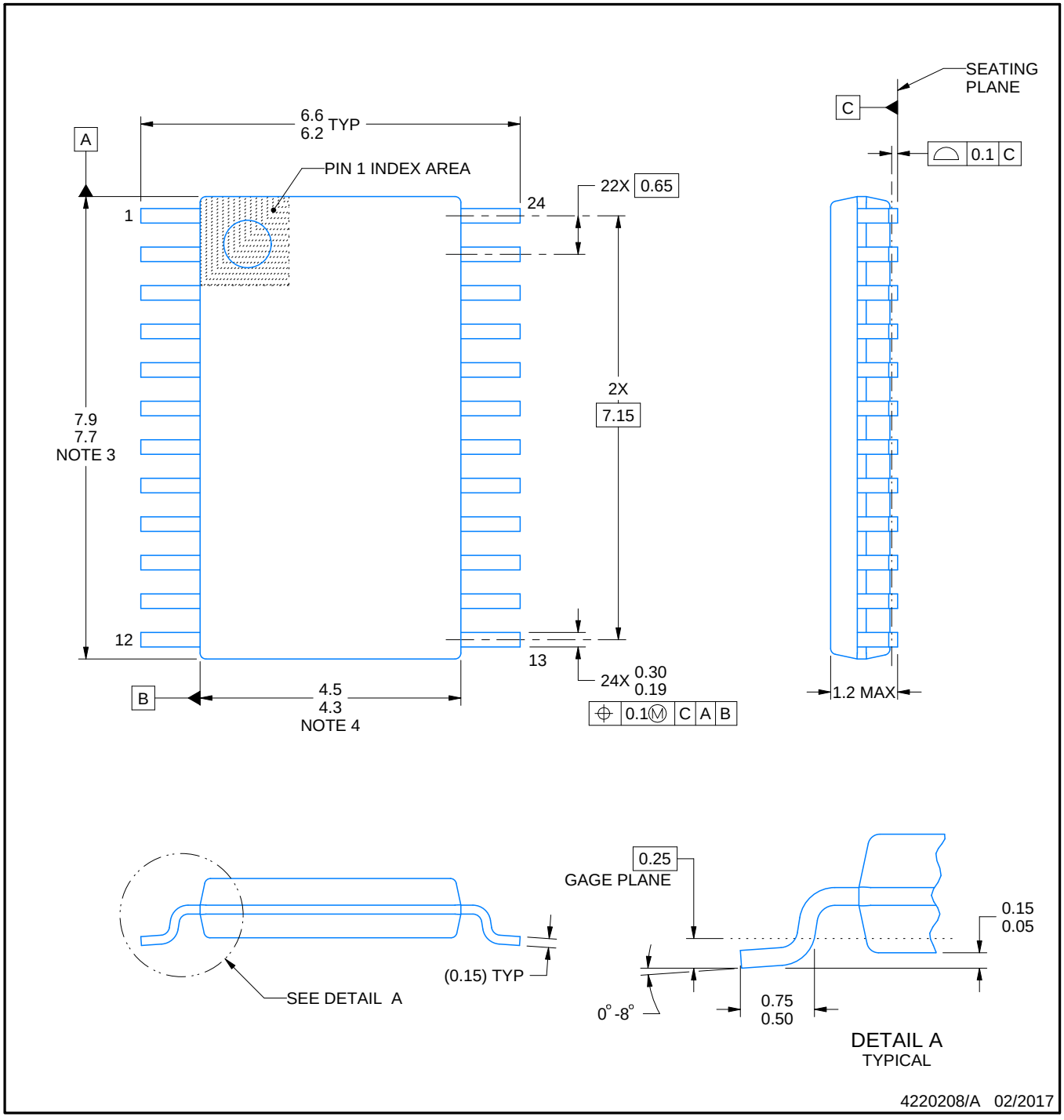
6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

PACKAGE OUTLINE

PW0024A

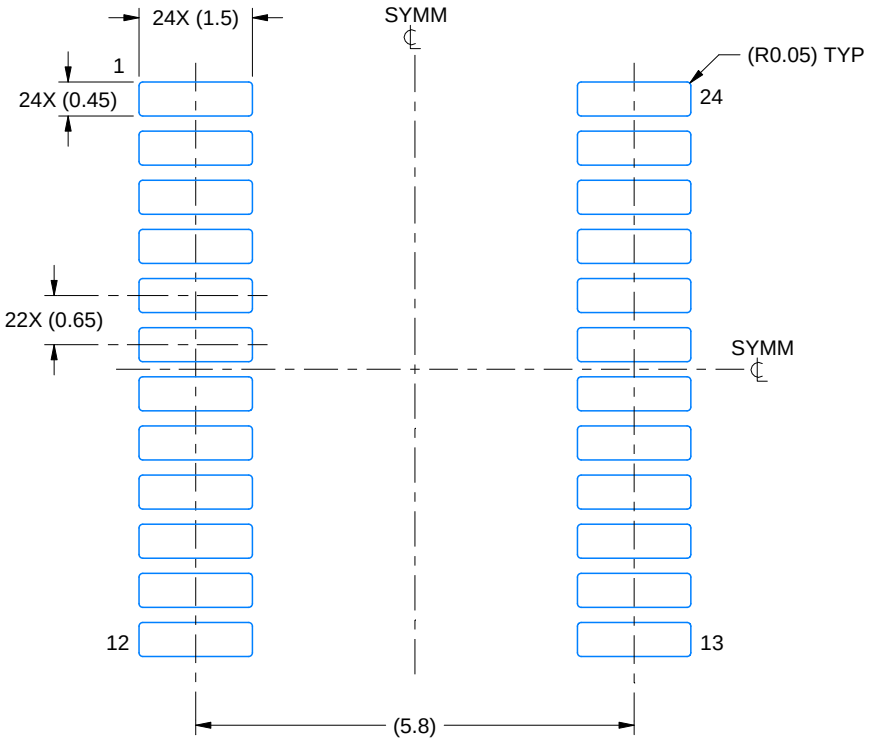
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

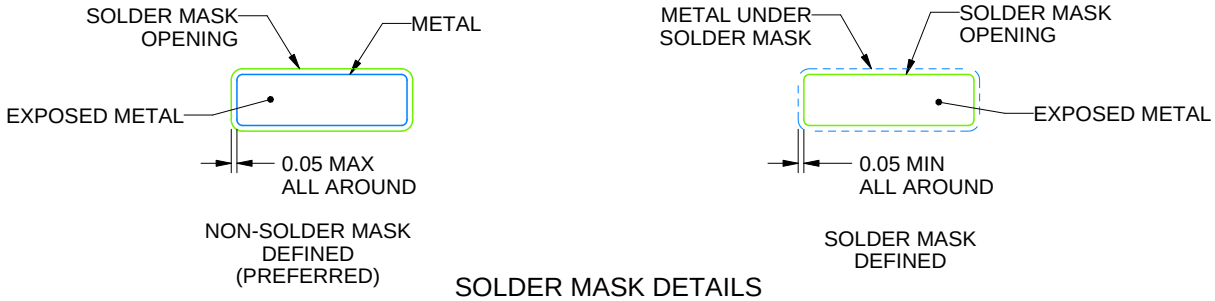


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

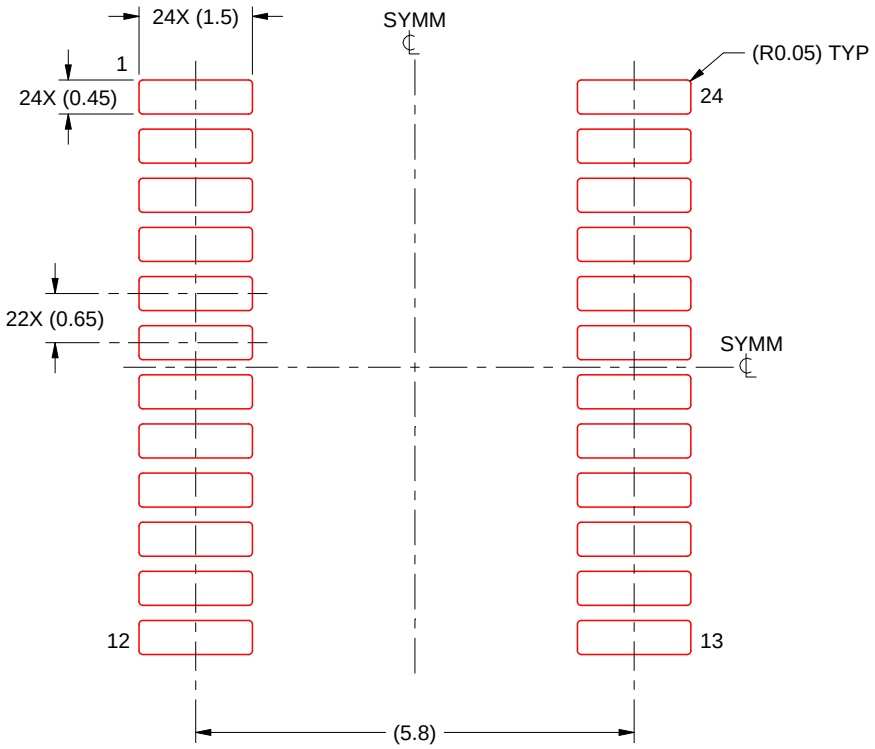


SOLDER MASK DETAILS

4220208/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220208/A 02/2017

NOTES: (continued)

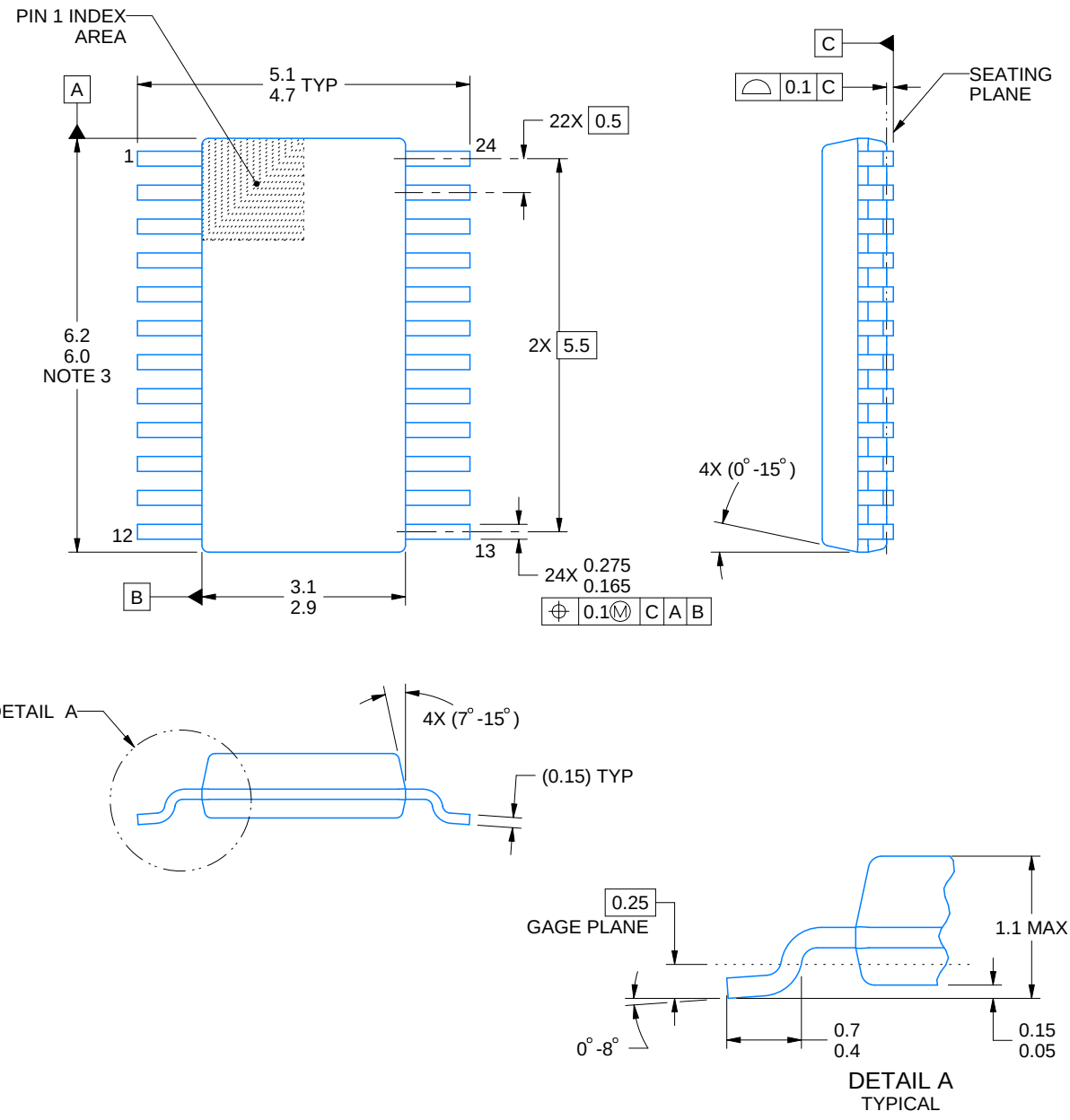
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

PACKAGE OUTLINE

DGS0024A

VSSOP - 1.1 mm max height

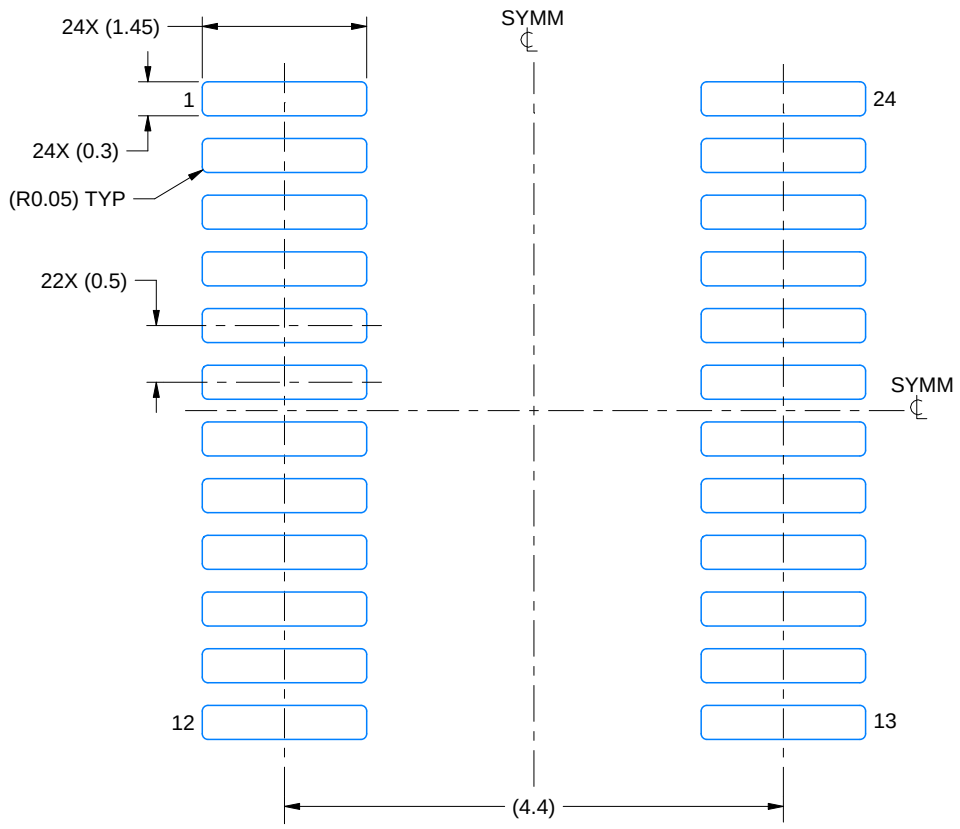
SMALL OUTLINE PACKAGE



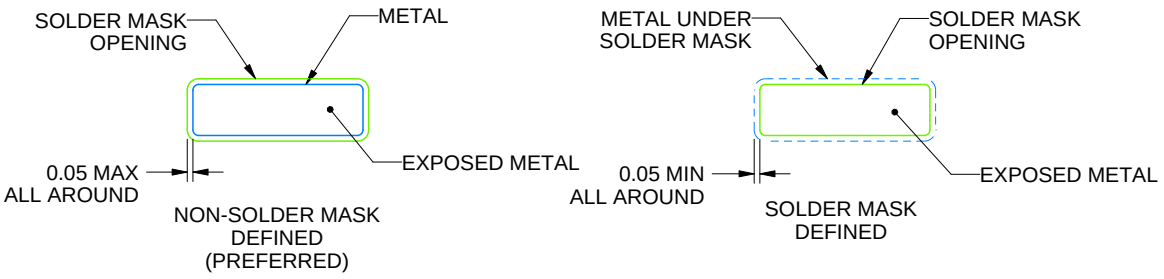
PowerPAD is a trademark of Texas Instruments.

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. No JEDEC registration as of September 2020.
5. Features may differ or may not be present.



LAND PATTERN EXAMPLE
SCALE: 15X

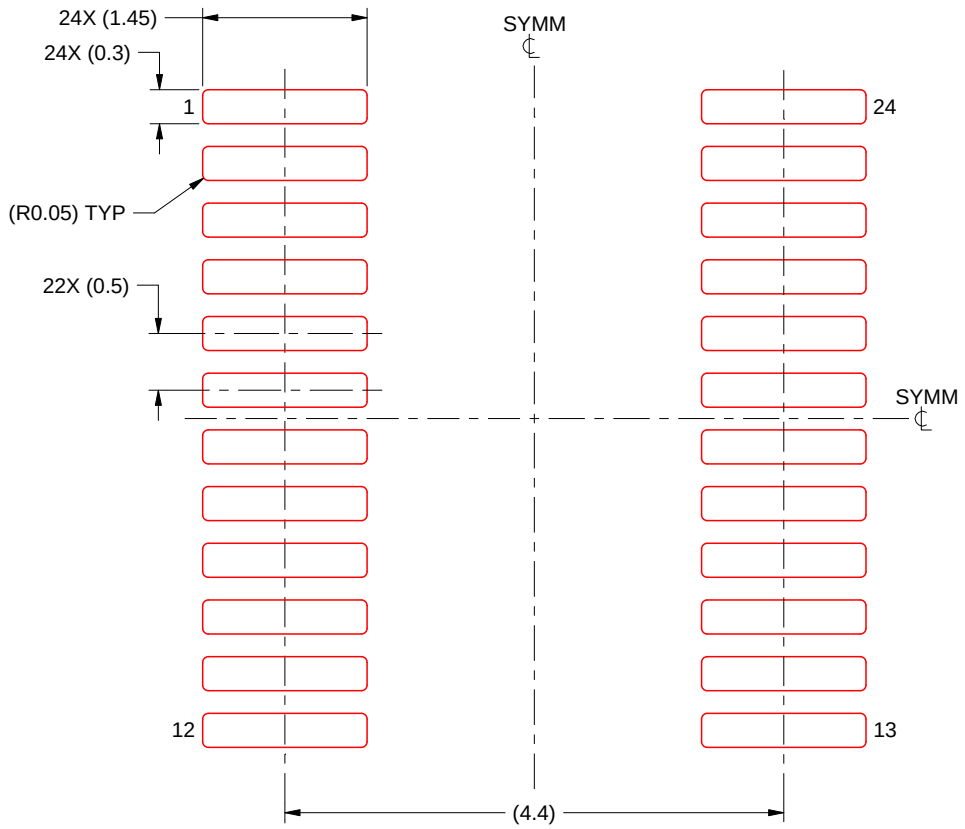


SOLDER MASK DETAILS

4226366/A 10/2020

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
9. Size of metal pad may vary due to creepage requirement.
10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 15X

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NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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